

Search Notes

Application/Control No.

10/624,327

Examiner

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Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
257	68,71	9/23/2004	AH
	295-314		
	324-326		
438	3,240		
257	\$.ccls.	2/4/2005	AH
438	\$.ccls.		
365	\$.ccls.		
Text	search	2/4/2005	AH
Text	search	2/9/2005	AH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	295,298	9/23/2004	AH
	303,306		
	324		
438/3,240		9/23/2004	AH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/23/2004	AH
EAST	2/4/2005	AH
EAST	2/9/2005	AH